


U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE 	ATTY. DOCKET NO. 890050.433	APPLICATION NO. 10/613,525
	APPLICANTS Hiroyasu Inoue et al.	
	FILING DATE July 3, 2003	GROUP ART UNIT 1774

## U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
BH	AA	5,194,363	03/16/93	Yoshioka et al.	430	271	
	AB	5,325,351	06/28/94	Uchiyama et al.	369	275.1	
	AC	5,414,451	05/09/95	Sugiyama et al.	347	258	
	AD	5,948,496	09/07/99	Kinoshita et al.	428	64.1	
	AE	6,210,860	04/03/01	Fukano et al.	430	270.12	
	AF	6,231,945	05/15/01	Miyamoto et al.	429	64.1	
	AG	6,266,299	07/24/01	Oshima et al.	369	13	
	AH	6,355,326	03/12/02	Lee et al.	428	64.1	
	AI	6,449,239	09/10/02	Uno et al.	369	275.1	
	AJ	6,636,477	10/21/03	Miyamoto et al.	369	286	
	AK	6,656,559	12/02/03	Mizushima et al.	428	64.1	
	AL	6,788,635	09/07/04	Aratani et al.	369	100	
	AM	6,805,935	10/19/04	Ashida et al.	428	64.1	
	AN	6,807,142	10/19/04	Nagata et al.	369	275.2	
	AO	6,841,218	01/11/05	Hosoda et al.	428	64.1	
	AP	6,982,111	01/03/06	Mizushima et al.	428	64.1	
	AQ	7,002,887	02/21/06	Kakiuchi et al.	369	5.12	
	AR	2001/0021160	09/13/01	Shuy et al.	369	100	
	AS	2001/0044073	11/22/01	Fukano et al.	430	270.12	
	AT	2002/0060979	05/23/02	Tsukuda et al.	369	275.4	
↓	AU	2003/0086359	05/08/03	Lee et al.	369	275.3	

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
BH	AV	62-28941	02/06/87	JP (+ Abstract in English)		

EXAMINER

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\* EXAMINER: Initial if reference considered, whether or not criteria is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant(s).

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE  <b>SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT</b> (Use several sheets if necessary)	ATTY. DOCKET NO. 890050.433	APPLICATION NO. 10/613,525
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*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
BH	BA	2003/0086359	05/08/03	Lee et al.	369	275.3	
	BB	2003/0165111	09/04/03	Flynn	369	288	
	BC	2003/0224215	12/04/03	Kondo et al.	428	694	
	BD	2004/0001418	01/01/04	Shinotsuka et al.	369	111	
	BE	2004/0018334	01/29/04	Nee	428	64.1	
	BF	2004/0027973	02/12/04	Aoshima et al.	369	121	
	BG	2004/0038080	02/26/04	Inoue et al.	428	694 SC	
	BH	2004/0076907	04/22/04	Inoue et al.	430	270.12	
	BI	2004/0110086	06/10/04	Kakiuchi et al.	430	270.12	
	BJ	2004/0152016	08/05/04	Mishima et al.	430	270.12	
	BK	2004/0157158	08/12/04	Kakiuchi et al.	430	270.12	
	BL	2004/0174804	09/09/04	Kakiuchi et al.	369	275.4	
	BM	2004/0191685	09/30/04	Kakiuchi et al.	430	270.11	
	BN	2004/0241581	12/02/04	Kakiuchi et al.	430	270.12	
	BO	2005/0018590	01/27/05	Inoue et al.	369	275.2	
	BP	2005/0018591	01/27/05	Inoue et al.	369	275.2	
	BQ	2005/0018592	01/27/05	Inoue et al.	369	275.2	
	BR	2005/0047301	03/03/05	Inoue et al.	369	94	
	BS	2005/0047302	03/03/05	Inoue et al.	369	94	
	BT	2005/0047303	03/03/05	Inoue et al.	369	94	
	BU	2005/0047304	03/03/05	Inoue et al.	369	94	
	BV	2005/0047305	03/03/05	Inoue et al.	369	94	
	BW	2005/0048249	03/03/05	Inoue et al.	428	64.4	
	BX	2005/0052194	03/10/05	Kister et al.	324	755	
↓	BY	2005/0074306	04/07/05	Montresor	409	179	

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